



SEMITRANS® 5

## Trench IGBT Modules

## SKM 300 GARL 066 T

## Features

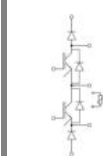
- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$  with positive temperature coefficient
- Integrated NTC temperature sensor

## Typical Applications\*

- UPS
- 3 Level Inverter

## Remarks

- Case temperature limited to  $T_c = 125^\circ\text{C}$  max
- Recommended  $T_{op} = -40..+150^\circ\text{C}$
- $T_{vj}$  is intended as absolute maximum rating
- Fig.2 is referred to IGBT current capability



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Absolute Maximum Ratings		T <sub>case</sub> = 25°C, unless otherwise specified		
Symbol	Conditions	Values	Units	
IGBT				
V <sub>CES</sub>	T <sub>j</sub> = 25 °C	600	V	
I <sub>C</sub>	T <sub>j</sub> = 175 °C	T <sub>c</sub> = 25 °C	400	A
		T <sub>c</sub> = 80 °C	300	A
I <sub>CRM</sub>	I <sub>CRM</sub> =2xI <sub>Cnom</sub>	600	A	
V <sub>GES</sub>		± 20	V	
t <sub>psc</sub>	V <sub>CC</sub> = 360 V; V <sub>GE</sub> ≤ 15 V; T <sub>j</sub> = 150 °C V <sub>CES</sub> < 600 V	6	μs	
Inverse Diode				
I <sub>F</sub>	T <sub>j</sub> = 175 °C	T <sub>c</sub> = 25 °C	40	A
		T <sub>c</sub> = 80 °C	30	A
I <sub>FRM</sub>	I <sub>FRM</sub> =2xI <sub>Fnom</sub>	60	A	
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms; half sine wave T <sub>j</sub> = 150 °C	160	A	
Freewheeling Diode				
I <sub>F</sub>	T <sub>j</sub> = 175 °C	T <sub>c</sub> = 25 °C	400	A
		T <sub>c</sub> = 80 °C	290	A
I <sub>FRM</sub>	I <sub>FRM</sub> =2xI <sub>Fnom</sub>	600	A	
I <sub>FSM</sub>	t <sub>p</sub> = 10 ms; half sine wave T <sub>j</sub> = 150 °C	2100	A	
Module				
I <sub>t(RMS)</sub>		500	A	
T <sub>vj</sub>		- 40 ... + 175	°C	
T <sub>stg</sub>		- 40 ... + 125	°C	
V <sub>isol</sub>	AC, 1 min.	2500	V	

Characteristics		$T_{case} = 25^\circ\text{C}$ , unless otherwise specified			
Symbol	Conditions	min.	typ.	max.	Units
<b>IGBT</b>					
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 4,8\text{ mA}$	5	5,8	6,5	V
$I_{CES}$	$V_{GE} = 0\text{ V}, V_{CE} = V_{CES}, T_j = 25^\circ\text{C}$			0,5	mA
$I_{GES}$	$V_{CE} = 0\text{ V}, V_{GE} = 20\text{ V}, T_j = 25^\circ\text{C}$			1200	nA
$V_{CE0}$			$T_j = 25^\circ\text{C}$	0,9	V
			$T_j = 150^\circ\text{C}$	0,85	V
$r_{CE}$	$V_{GE} = 15\text{ V}$		$T_j = 25^\circ\text{C}$	1,8	$\text{m}\Omega$
			$T_j = 150^\circ\text{C}$	2,7	$\text{m}\Omega$
$V_{CE(sat)}$	$I_{Cnom} = 300\text{ A}, V_{GE} = 15\text{ V}$		$T_j = 25^\circ\text{C}_{chiplev.}$	1,45	V
			$T_j = 150^\circ\text{C}_{chiplev.}$	1,7	V
$C_{ies}$	$V_{CE} = 25, V_{GE} = 0\text{ V}, f = 1\text{ MHz}$		18,4		nF
$C_{oes}$			1,14		nF
$C_{res}$			0,54		nF
$Q_G$	$V_{GE} = -15\text{V}...+15\text{V}$		3900		nC
$R_{Gint}$	$T_j = ^\circ\text{C}$		1		$\Omega$
$t_{d(on)}$	$R_{Gon} = 2,2\ \Omega$ $di/dt = 3400\text{ A}/\mu\text{s}$	$V_{CC} = 300\text{V}$ $I_C = 300\text{A}$	140		ns
$t_r$			89		ns
$E_{on}$	$R_{Goff} = 2,2\ \Omega$ $di/dt = 3400\text{ A}/\mu\text{s}$	$T_j = 150^\circ\text{C}$ $V_{GE} = -15\text{V}/+15\text{V}$	3,5		mJ
$t_{d(off)}$			433		ns
$t_f$			116		ns
$E_{off}$			10,1		mJ
$R_{th(j-c)}$	per IGBT		0,15		K/W

# SKM 300 GARL 066 T



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Characteristics					
Symbol	Conditions	min.	typ.	max.	Units
<b>Inverse Diode</b>					
$V_F = V_{EC}$	$I_{Fnom} = 30\text{ A}; V_{GE} = 0\text{ V}$				
	$T_j = 25^\circ\text{C}_{chiplev.}$		1,45	1,7	V
	$T_j = 150^\circ\text{C}_{chiplev.}$		1,45	1,7	V
$V_{F0}$					
	$T_j = 25^\circ\text{C}$		1	1,1	V
	$T_j = 150^\circ\text{C}$		0,9	1	V
$r_F$					
	$T_j = 25^\circ\text{C}$		15	20	mΩ
	$T_j = 150^\circ\text{C}$		18	23,3	mΩ
$I_{RRM}$	$I_F = 30\text{ A}$				A
$Q_{rr}$					μC
$E_{rr}$	$V_{GE} = -8\text{ V}; V_{CC} = 300\text{ V}$				mJ
$R_{th(j-c)D}$	per diode		2		K/W
<b>Free-wheeling diode</b>					
$V_F = V_{EC}$	$I_{Fnom} = 300\text{ A}; V_{GE} = 0\text{ V}$				
	$T_j = 25^\circ\text{C}_{chiplev.}$		1,35	1,6	V
	$T_j = 150^\circ\text{C}_{chiplev.}$		1,3	1,5	V
$V_{F0}$					
	$T_j = 25^\circ\text{C}$		0,9	1	V
	$T_j = 150^\circ\text{C}$		0,85	0,9	V
$r_F$					
	$T_j = 25^\circ\text{C}$		1,5	2	V
	$T_j = 150^\circ\text{C}$		1,5	2	V
$I_{RRM}$	$I_F = 300\text{ A}$				A
$Q_{rr}$			194		μC
$E_{rr}$	$V_{GE} = 0\text{ V}; V_{CC} = 600\text{ V}$		13		mJ
			4		
$R_{th(j-c)FD}$	per diode		0,28		K/W
$R_{th(c-s)}$	per module			0,038	K/W
$M_s$	to heat sink M6	3		5	Nm
$M_t$	to terminals M6	2,5		5	Nm
w				310	g
<b>Temperature sensor</b>					
$R_{100}$	$T_s = 100^\circ\text{C} (R_{25} = 5\text{ k}\Omega)$		493±5%		Ω
					K

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

\* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our staff.



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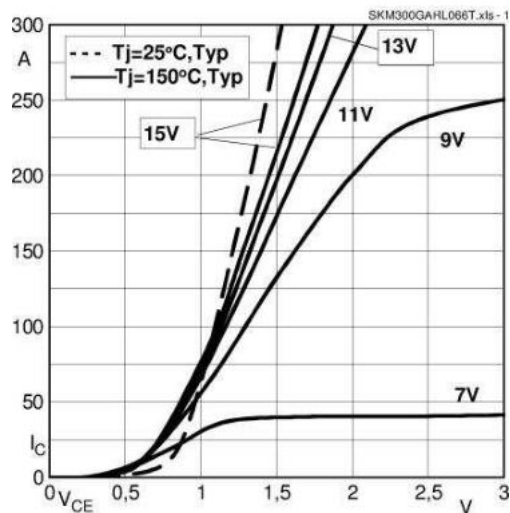


Fig. 1 Typ. output characteristic, inclusive  $R_{CC'+EE'}$

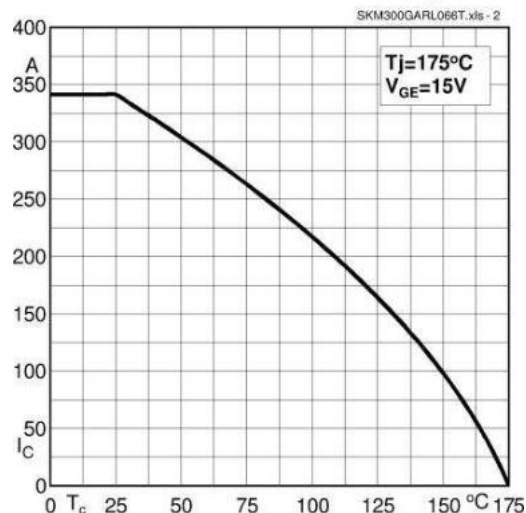


Fig. 2 Rated current vs. temperature  $I_C = f(T_C)$

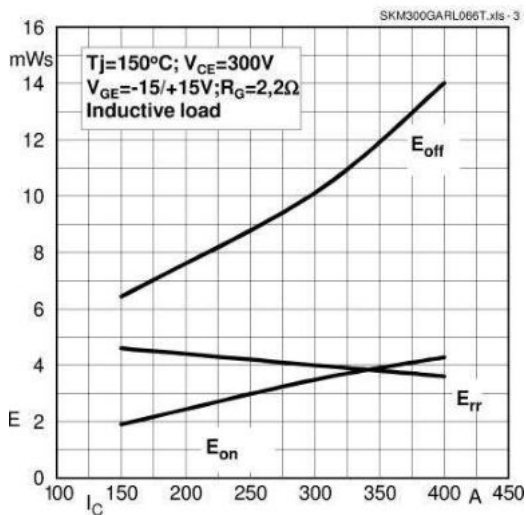


Fig. 3 Typ. turn-on /-off energy =  $f(I_C)$

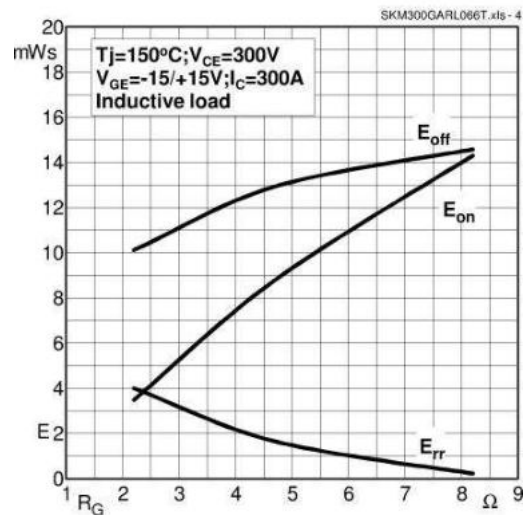


Fig. 4 Typ. turn-on /-off energy =  $f(R_G)$

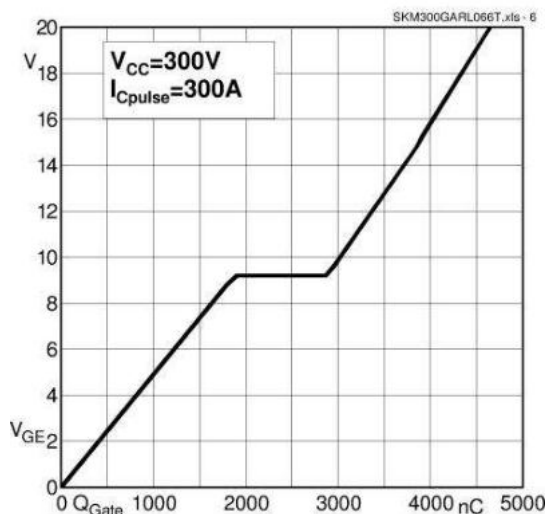
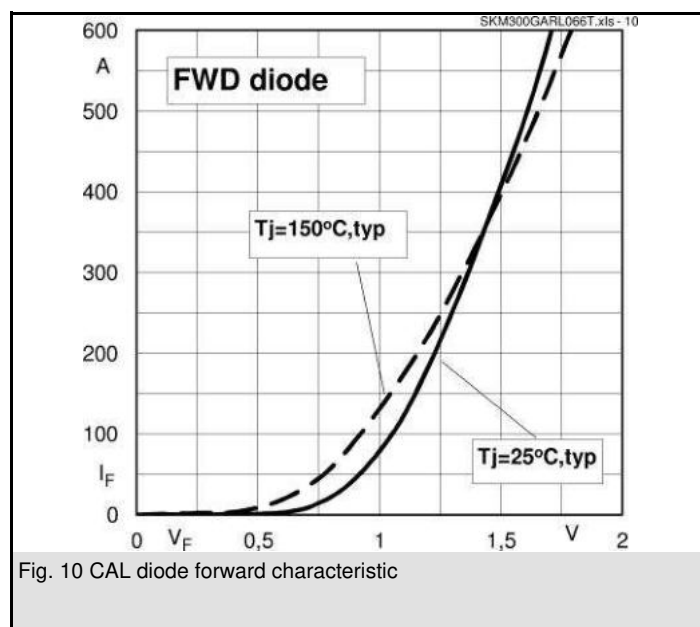
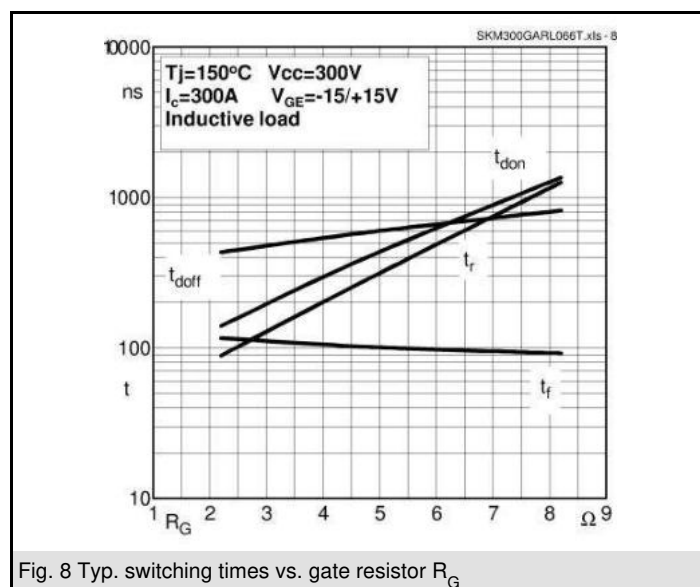
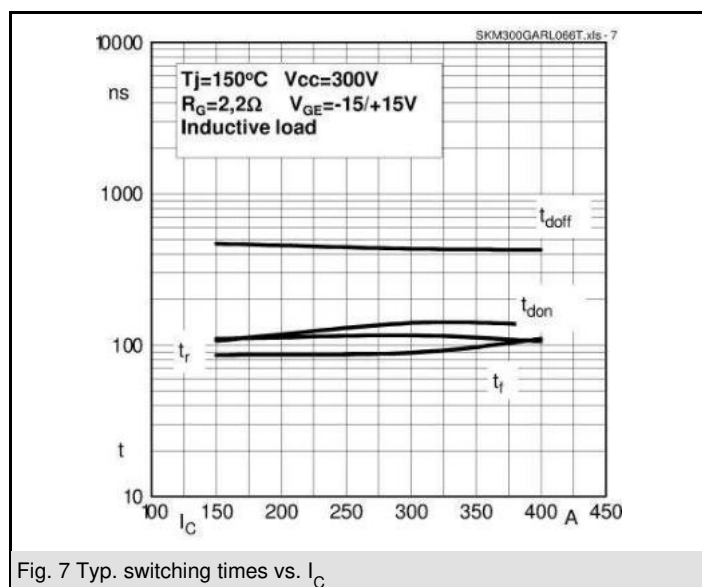
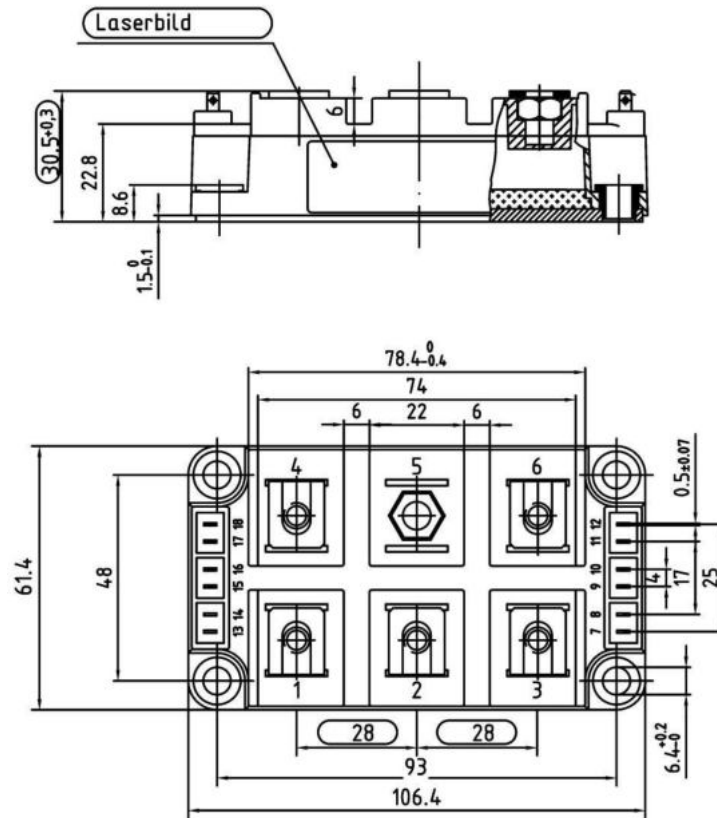


Fig. 6 Typ. gate charge characteristic

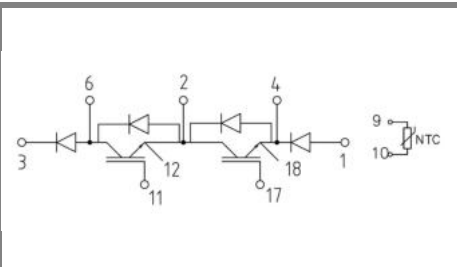


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Case D61



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Case D61